

**Search Notes**

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Examiner

Cong-Lac Huynh

Applicant(s)/Patent under  
Reexamination

LUE, VINCENT WEN-JENG

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
715	513	11/1/2007	CLH
	514	11/1/2007	CLH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
715	513	11/1/2007	CLH
	514	11/1/2007	CLH
Interference Search History Printout		11/5/2007	CLH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (USPAT, USPGPUB, JPO, EPO, Derwent)	11/1/2007	CLH
ACM	11/1/2007	CLH
Google	11/1/2007	CLH